

Characterisation of Silicon Photomultipliers for Time-Of-Flight Applications

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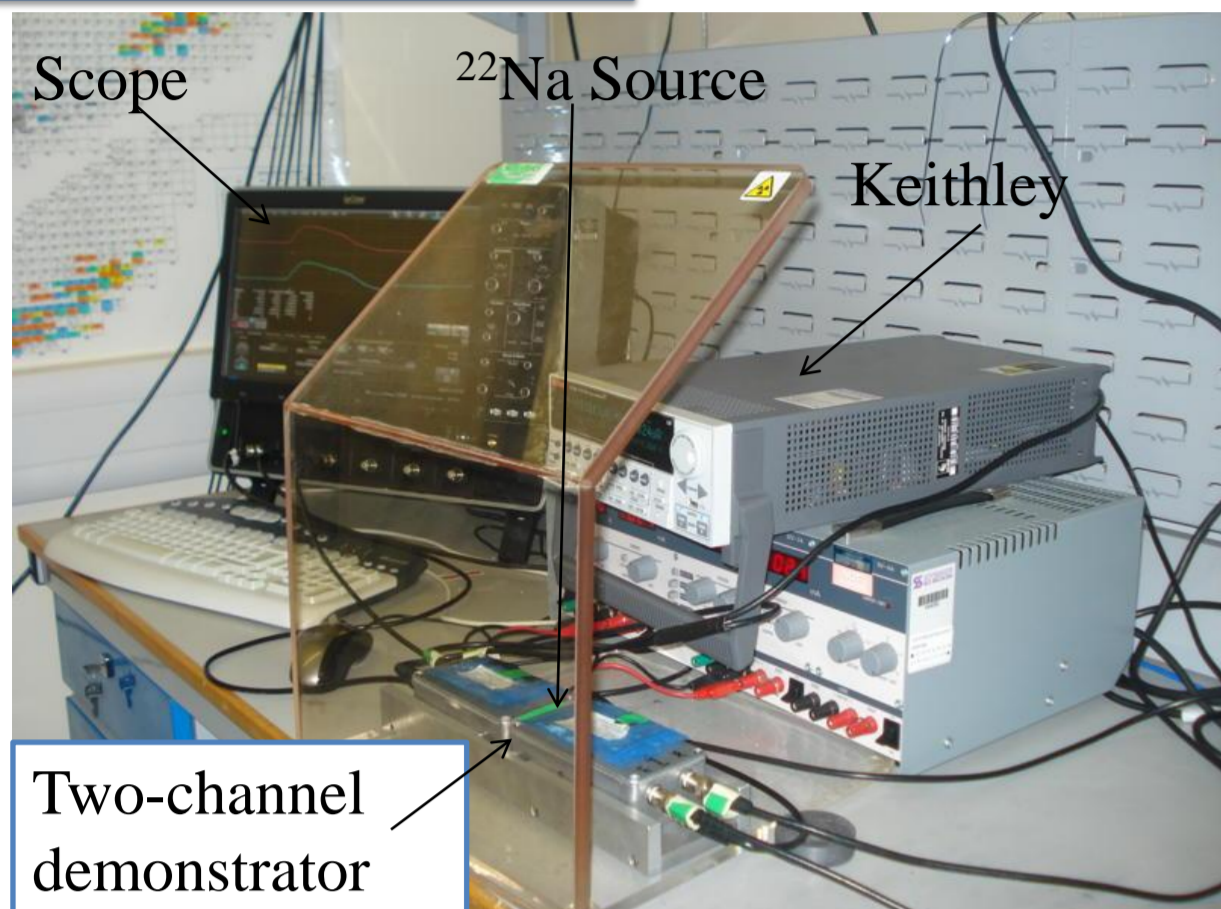
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The recently developed Silicon PhotoMultiplier (SiPM) is a solid state photon detector operating in the Geiger mode. Due to avalanche nature of its signal, it has a fast response time; this makes it an ideal candidate for use in fast Time-Of-Flight (TOF) applications. This work is aimed at the application of TOF to medical imaging. In this study we characterised SiPMs from three manufacturers: breakdown voltages, dark count rates, rise times of dark noise signals and signal in response to light sources were measured. Two-channel demonstrators were built coupling SiPMs to LaBr₃(Ce) and LYSO crystals and their time performances were studied. The best timing resolution was measured to be 298ps (σ).

1. The system

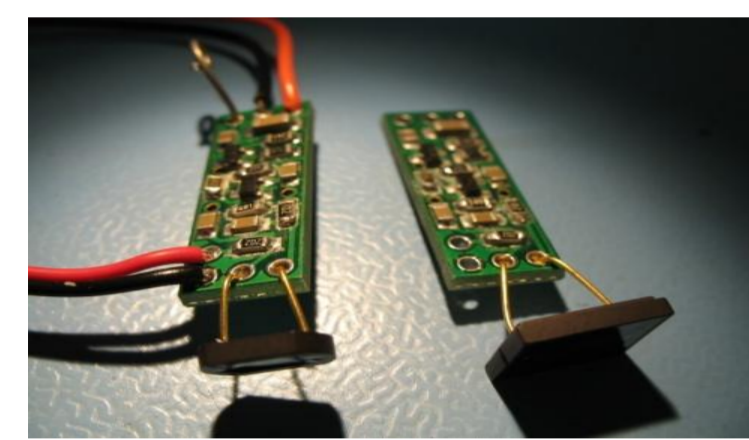


Electronics:

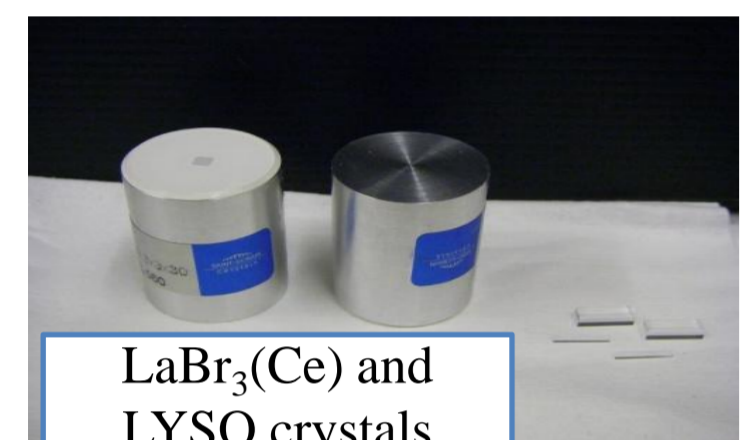
1. Read-out boards: preamp boards from Photonique, ~ 700ps rise time, gain 10x-20x
2. Power supply: Keithley 2612 two-channel sourcemeter 200V

DAQ: Lecroy Wave Pro 725Zi 2.5GHz oscilloscope, 40GHz sampling rate

The experimental set-up for timing resolution studies



SiPMs & Photonique boards



LaBr₃(Ce) and LYSO crystals

Manufacturer	Area (mm ²)	Cell Size
Hamamatsu	1x1	25 μ m, 50 μ m, 100 μ m
	3x3	25 μ m, 50 μ m, 100 μ m
Photonique	1x1	No information
	2x2	No information
SensL	1x1	No information
	3x3	No information

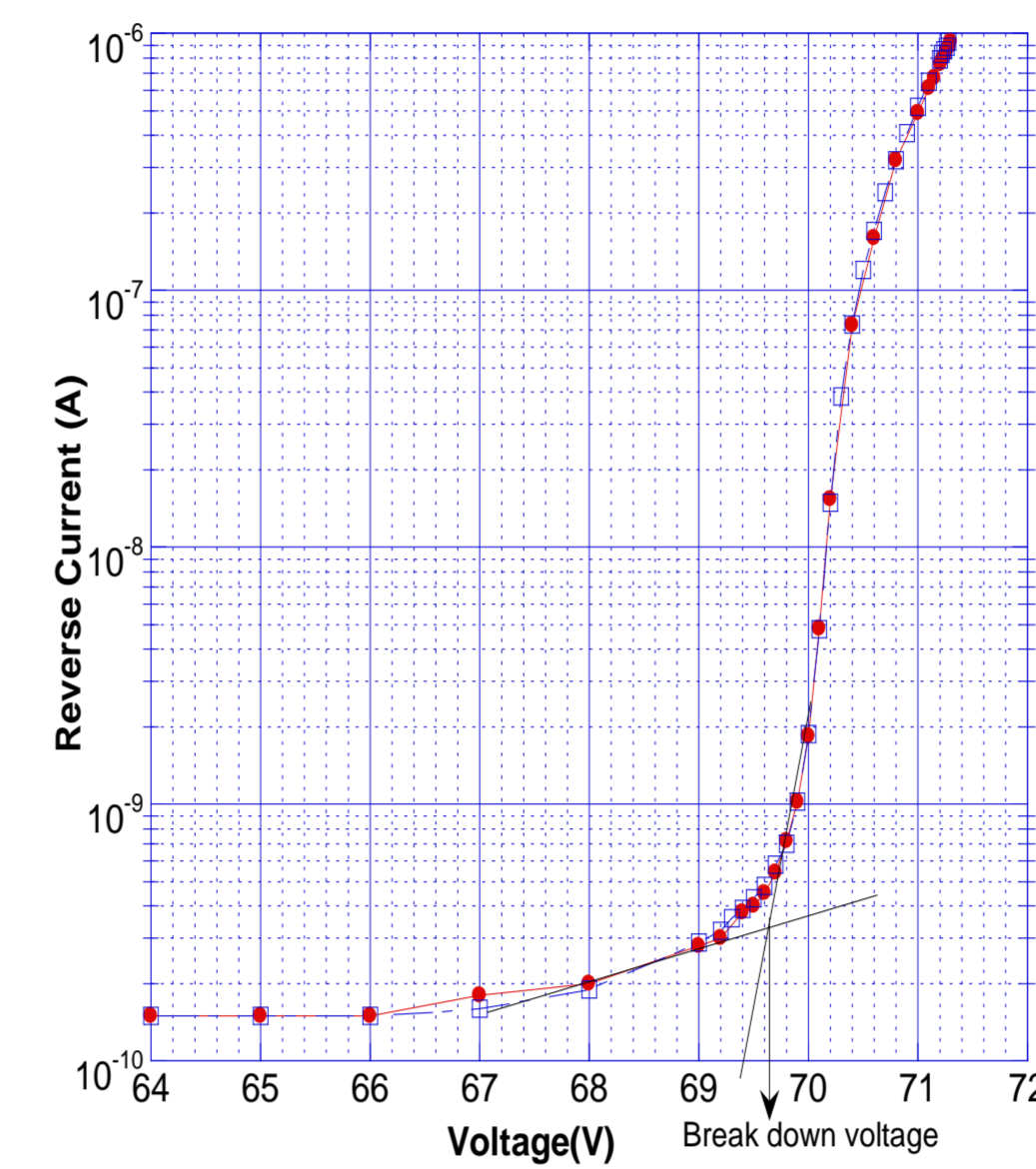
Crystal	Area (mm ²)	Length (mm)
LYSO	1x1	5
		10
	3x3	5
		10
4x4	5	
	10	
LaBr ₃ (Ce)	3x3	30

Sources:

1. For SiPM characterisation: blue (450nm peak-emission) LED and 1050nm Laser both from PicoQuant
2. For timing resolution studies of two-channel demonstrators: ²²Na source

2. I-V curves and breakdown voltages

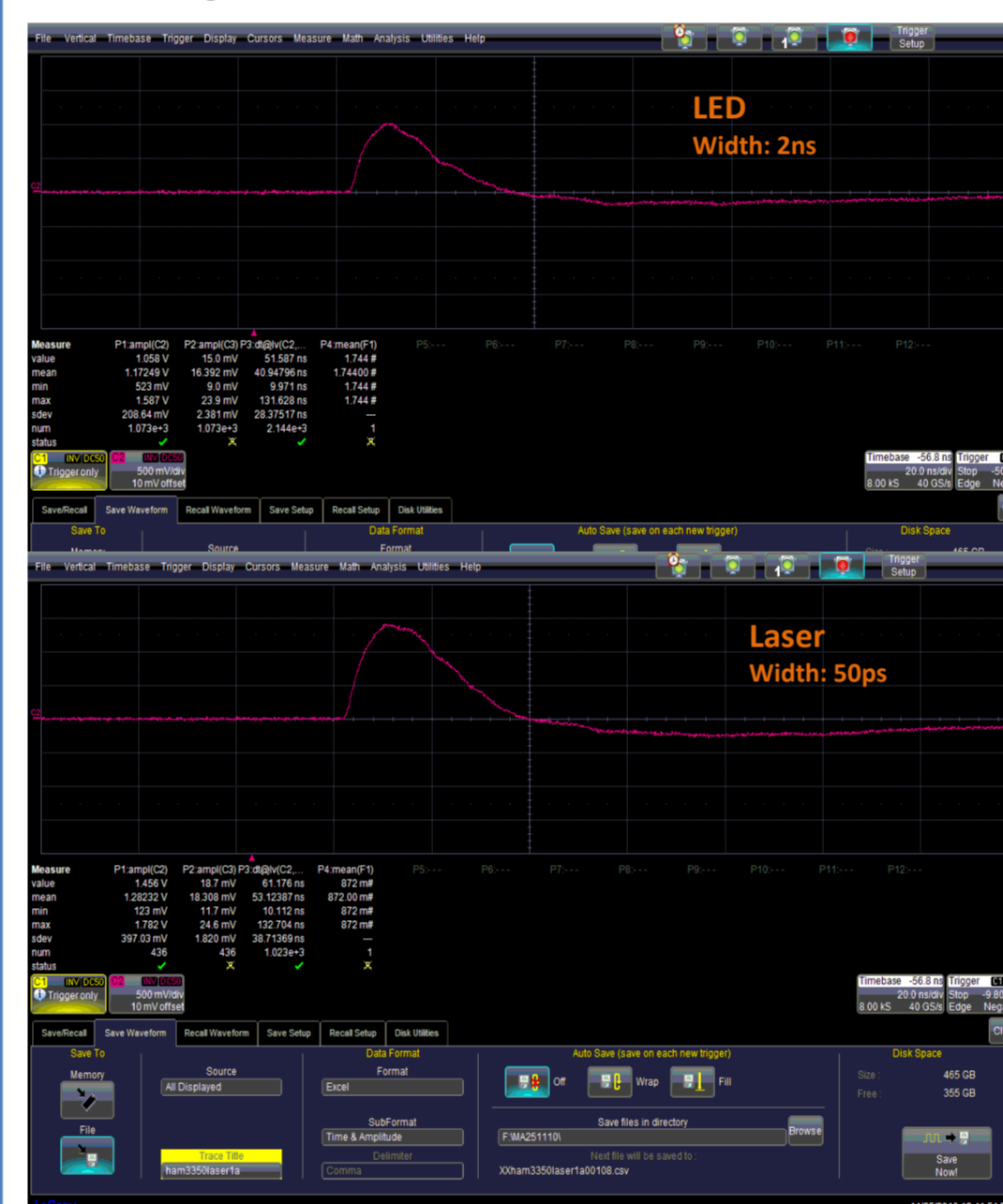
Breakdown voltages were calculated for all SiPMs. These breakdown voltages were found to be in the range 1.0-2.0V below the operating point (V_{bias}) recommended by the manufacturers.



SiPM	Breakdown Voltage (V)	Recommended V_{bias} (V)
Hamamatsu 3x3mm ² 25 μ m	SiPM 1	69.60
	SiPM 2	69.60
Hamamatsu 3x3mm ² 50 μ m	SiPM 1	69.60
	SiPM 2	69.60
Hamamatsu 3x3mm ² 100 μ m	SiPM 1	69.40
	SiPM 2	69.30
Hamamatsu 1x1mm ² 25 μ m	SiPM 1	68.60
	SiPM 2	69.50
Hamamatsu 1x1mm ² 50 μ m	SiPM 1	68.20
	SiPM 2	68.20
Hamamatsu 1x1mm ² 100 μ m	SiPM 1	69.20
	SiPM 2	68.60
Photonique 1x1mm ²	SiPM 1	17.20
	SiPM 2	17.30
Photonique 2x2mm ²	SiPM 1	26.50
	SiPM 2	26.50
SensL 1x1mm ²	SiPM 1	28.20
	SiPM 2	28.20
SensL 3x3mm ²	SiPM 1	27.50
	SiPM 2	27.50

4. Rise time studies

Light sources



Dark noise

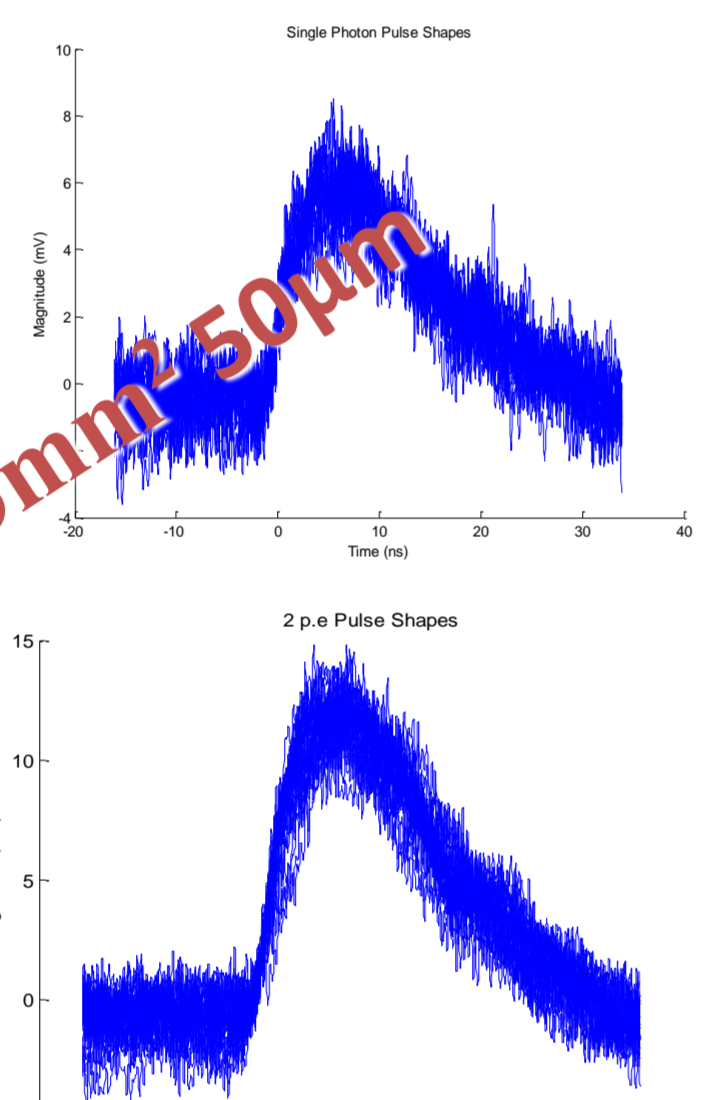
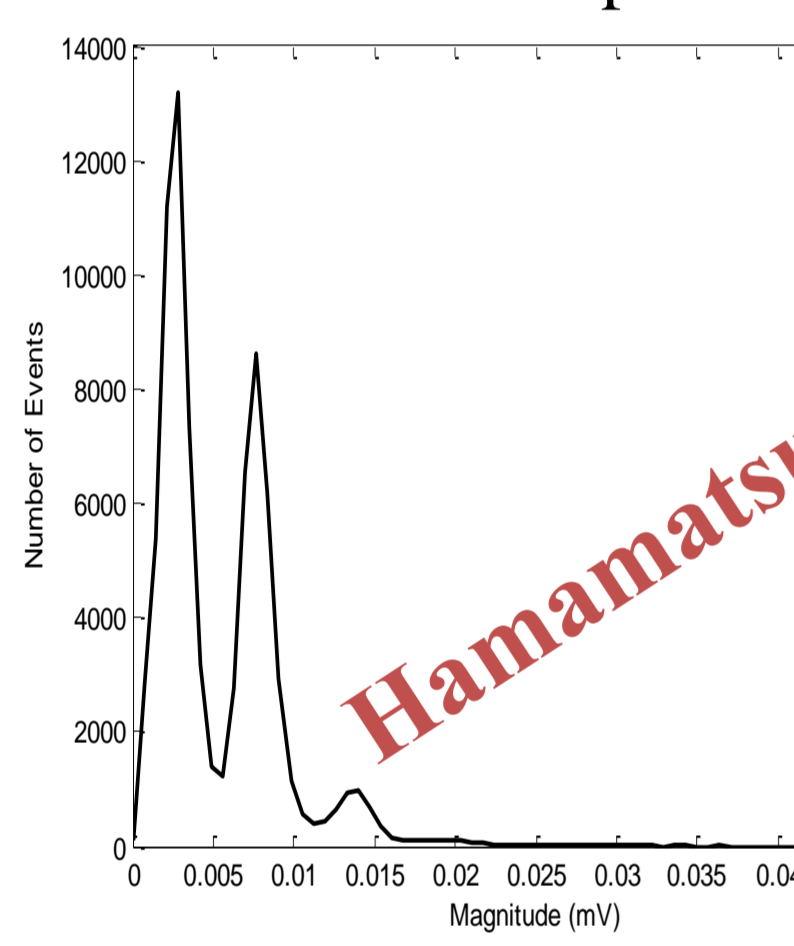


Rise time from LED and Laser

SiPM	Rise time (ns)	
	LED	Laser
Hamamatsu 1x1mm ² 25 μ m	2.4	2.3
Hamamatsu 1x1mm ² 50 μ m	4.8	5.3
Hamamatsu 1x1mm ² 100 μ m	5.9	6.1
Hamamatsu 3x3mm ² 25 μ m	4.1	4.7
Hamamatsu 3x3mm ² 50 μ m	4.2	5.3
Hamamatsu 3x3mm ² 100 μ m	6.2	6.2
Photonique 1x1mm ²	1.8	1.8
Photonique 2x2mm ²	2.7	2.6
SensL 1x1mm ²	5.4	5.9
SensL 3x3mm ²	6.6	7.1

3. The dark noise

Dark noise spectra

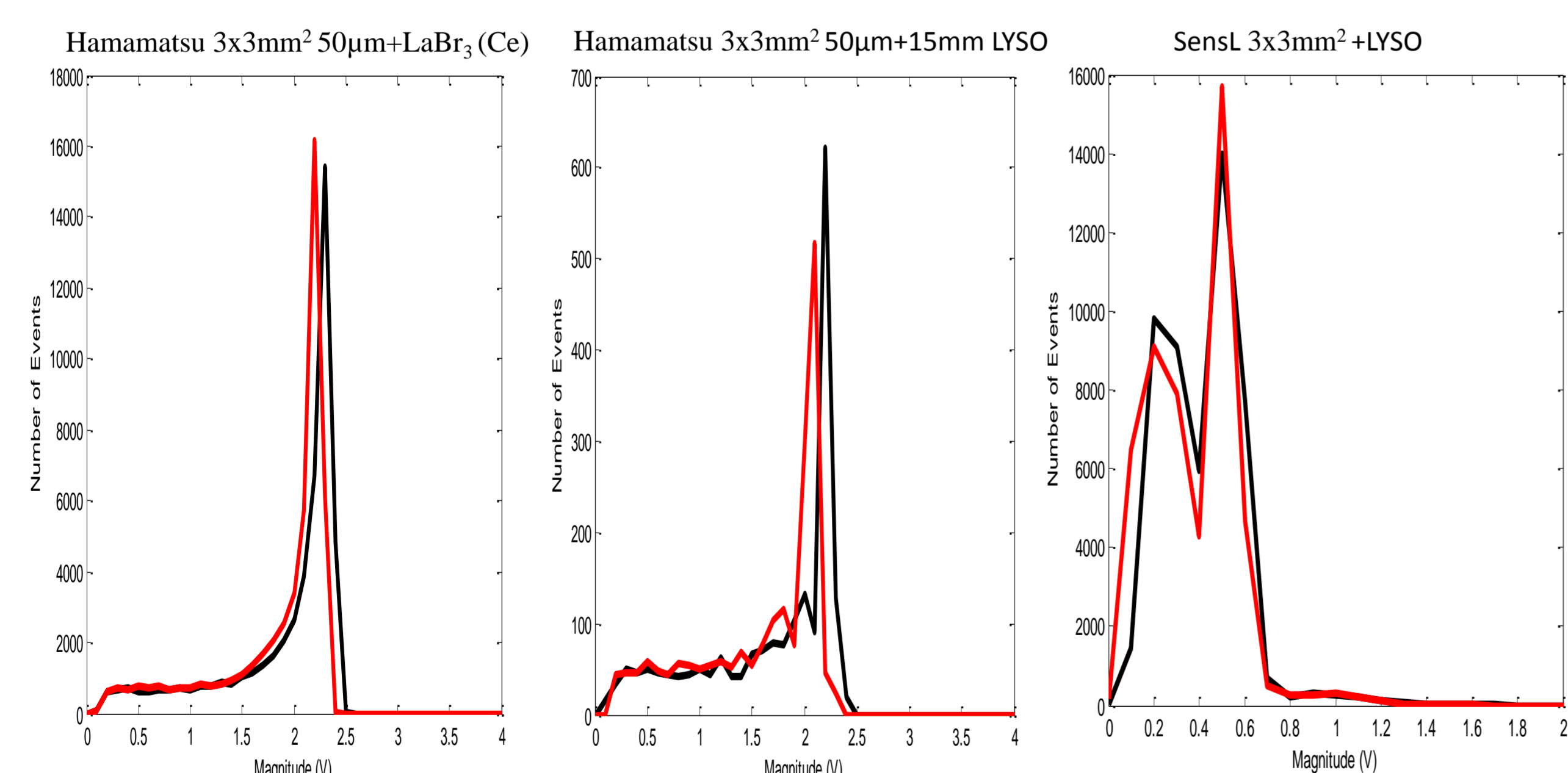


Dark count rates

SiPM	Measure dark count rates (kHz)	Manufacturer data (kHz)
Hamamatsu 1x1mm ² 25 μ m	0.40	0.30
Hamamatsu 1x1mm ² 50 μ m	0.72	0.40
Hamamatsu 1x1mm ² 100 μ m	0.66	0.60
Hamamatsu 3x3mm ² 25 μ m	1.50	1.50
Hamamatsu 3x3mm ² 50 μ m	4.00	3.00
Hamamatsu 3x3mm ² 100 μ m	3.54	3.50
Photonique 1x1mm ²	9.00	-
Photonique 2x2mm ²	17.27	-
SensL 1x1mm ²	1.40	-
SensL 3x3mm ²	6.28	-
SensL 3x3mm ² new 8" wafer	3.35	-

Data taken at manufacturer recommended V_{bias}

5. Timing resolution studies for two-channel demonstrators



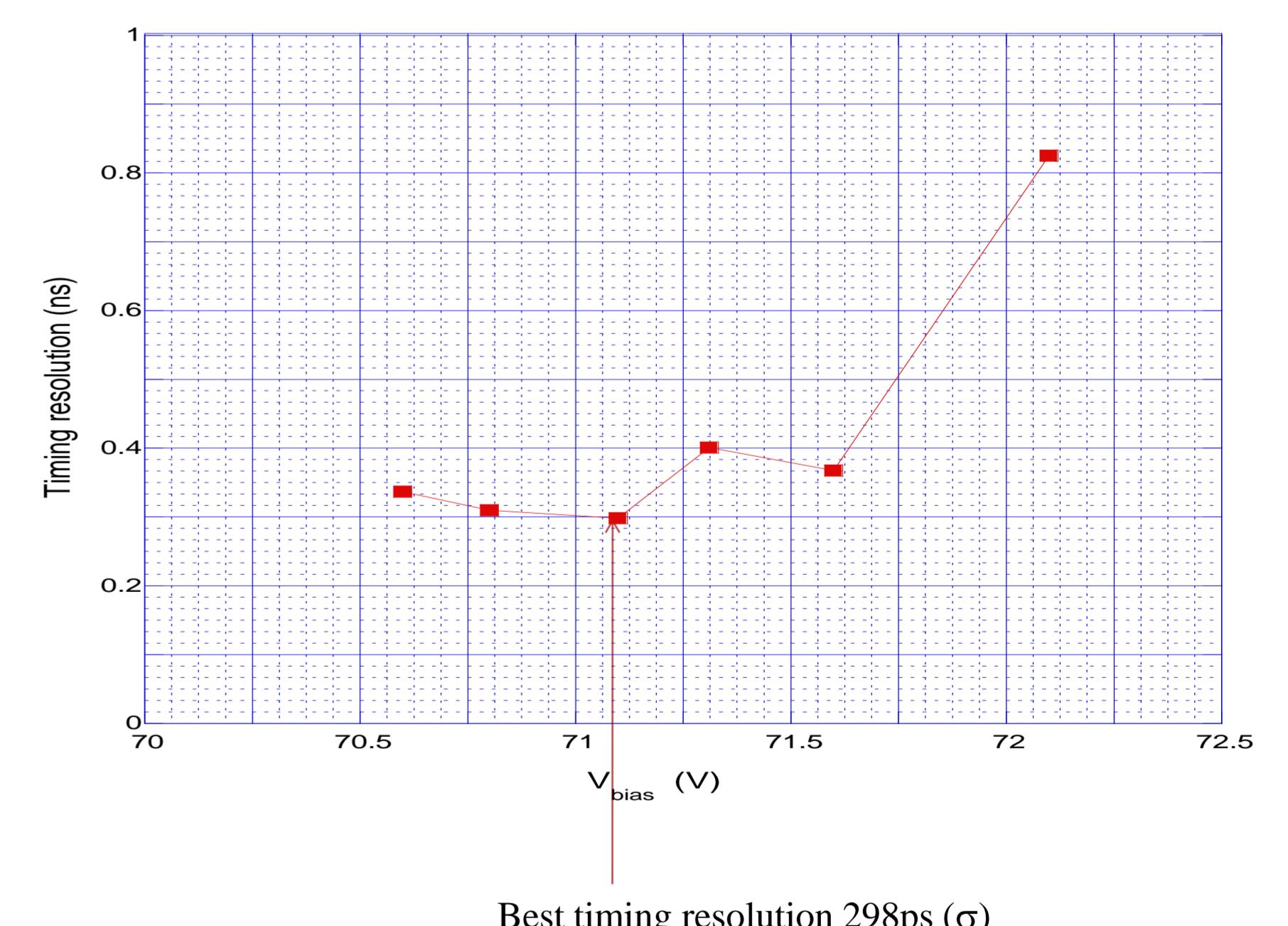
Output signals of three different two-channel demonstrators, clearly showing the 511 keV peaks from ²²Na

- Timing resolutions at SiPM fixed V_{bias} recommended by manufacturers:
 - The best timing resolution is 321ps (σ), obtained for 5mm length LYSO + Hamamatsu 3x3mm² 50 μ m

Timing resolution at fixed V_{bias}

SiPM	Crystal	Crystal size (mm ³)	Timing resolution (σ) (ns)
SensL 3x3mm ²	LYSO Hilger Analytical Limited	3x3x15	1.509
	LYSO Saint-Gobain	3x3x10	1.483
SensL 3x3mm ² new 8" wafer	LYSO Hilger Analytical Limited	3x3x15	1.420
	LYSO Saint-Gobain	3x3x10	1.416
Hamamatsu 3x3mm ² 50 μ m	LYSO Hilger Analytical Limited	3x3x15	0.363
	LYSO Saint-Gobain	3x3x10	0.358
	LaBr ₃ (Ce) Saint-Gobain	3x3x30	0.321

Timing resolution -vs- V_{bias}



Best timing resolution 298ps (σ)

- Timing resolution as function of SiPM V_{bias} :
 - Carried out only for LaBr₃(Ce) + Hamamatsu 3x3mm² 50 μ m
 - Best timing resolution of 298ps (σ) measured at 0.2V below recommended V_{bias}

6. Conclusions and future work

A preliminary characterisation of SiPMs was carried out using a simple data acquisition system based on a fast oscilloscope. Breakdown voltages, dark count rates and signal rise times were measured for all SiPMs. The timing resolutions of two-channel demonstrators were measured and the best one was found to be 298ps (σ). This preliminary result is comparable to other ones reported in literature. Based on our results we identified our system limitation in the read-out electronics, which we are in the process of upgrading. We are expecting further improvements in the timing performances with properly engineered two-channel demonstrator systems and set-ups.

Plan for future work:

- Acquire faster pre-amplifiers for the Hamamatsu 1x1mm² 50 μ m and Hamamatsu 3x3mm² 50 μ m SiPMs that are better matched to their capacitance and repeat measurements with these devices.
- Investigate the effects on the timing resolution of the crystal size and of the Ce concentration in the case of LaBr₃(Ce).